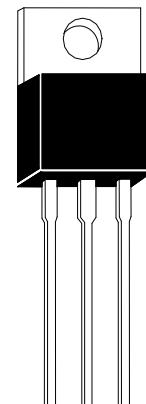


## N-Channel Enhancement Mode Power MOSFET

TO-220

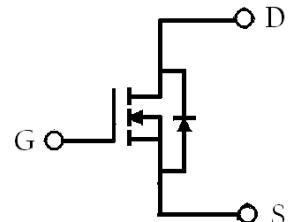
### Features:

- Low Gate Charge
- Simple Drive Requirement
- Repetitive Avalanche Rated
- Fast Switching Characteristic
- RoHS compliant package



G D S

BV <sub>DSS</sub>	60V
I <sub>D</sub> @ V <sub>GS</sub> =10V, T <sub>c</sub> =25°C	85A
R <sub>DSON(TYP)</sub> @ V <sub>GS</sub> =10V, I <sub>D</sub> =30A	7.4mΩ
R <sub>DSON(TYP)</sub> @ V <sub>GS</sub> =7V, I <sub>D</sub> =20A	8.1mΩ



G : Gate

D : Drain

S : Source

### Ordering Information

Device	Package	Shipping
KE09N06	TO-220 (Pb-free lead plating package)	50 pcs/tube, 20 tubes/box, 4 boxes / carton

## Absolute Maximum Ratings ( $T_C=25^\circ C$ , unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V <sub>DS</sub>	60	<b>V</b>
Gate-Source Voltage	V <sub>GSS</sub>	$\pm 30$	
Continuous Drain Current @ $T_C=25^\circ C$ , $V_{GS}=10V$ (silicon limit)	ID	85	<b>A</b>
Continuous Drain Current @ $T_C=100^\circ C$ , $V_{GS}=10V$ (silicon limit)		60	
Continuous Drain Current @ $T_C=25^\circ C$ , $V_{GS}=10V$ (package limit) (Note 1)		60	
Pulsed Drain Current (Note 3)	IDM	240	<b>A</b>
Continuous Drain Current @ $T_A=25^\circ C$ (Note 2)	IDS <sub>M</sub>	11	
Continuous Drain Current @ $T_A=70^\circ C$ (Note 2)		8.8	
Avalanche Current (Note 3)	I <sub>AS</sub>	30	
Avalanche Energy @ $L=1mH$ , $I_D=30A$ , $R_G=25\Omega$ (Note 2)	E <sub>AS</sub>	450	<b>mJ</b>
Repetitive Avalanche Energy@ $L=0.1mH$ (Note 3)	E <sub>AR</sub>	14	
Power Dissipation	P <sub>D</sub>	136	<b>W</b>
		68	
Power Dissipation	P <sub>DSM</sub>	2	<b>W</b>
		1.3	
Operating Junction and Storage Temperature	T <sub>j</sub> , T <sub>stg</sub>	-55~+175	°C

## Thermal Data

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R <sub>θJC</sub>	1.1	°C/W
Thermal Resistance, Junction-to-ambient, max, $t \leq 10s$ (Note 1)	R <sub>θJA</sub>	15	
Thermal Resistance, Junction-to-ambient, max (Note 1)		62.5	

- Note : 1. The power dissipation P<sub>D</sub> is based on  $T_{J(MAX)}=175^\circ C$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.  
 2. The value of R<sub>θJA</sub> is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2 oz. copper, in a still air environment with  $T_A=25^\circ C$ . The power dissipation P<sub>DSM</sub> is based on R<sub>θJA</sub> and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.  
 3. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}=175^\circ C$ . Ratings are based on low frequency and low duty cycles to keep initial T<sub>j</sub>=25°C.  
 4. The maximum current limited by package is 60A.  
 5. The static characteristics are obtained using <300μs pulses, duty cycle 0.5% maximum.  
 6. The R<sub>θJA</sub> is the sum of thermal resistance from junction to case R<sub>θJC</sub> and case to ambient.

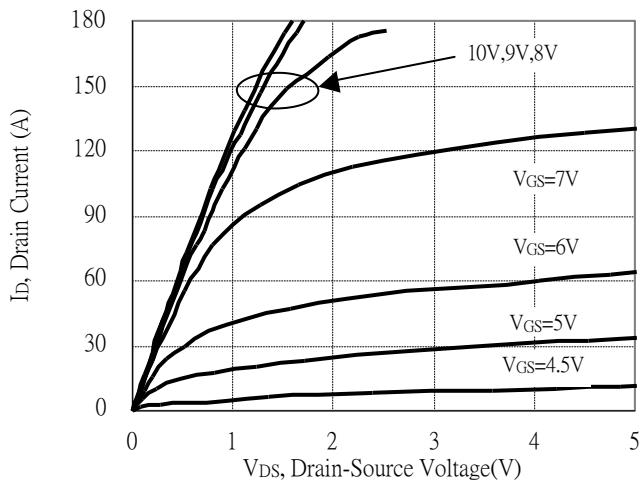
**Characteristics (T<sub>c</sub>=25°C, unless otherwise specified)**

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	60	-	-	V	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA
V <sub>GS(th)</sub>	2.0	-	4.0		V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> =250μA
G <sub>FS</sub>	-	30	-	S	V <sub>DS</sub> =5V, I <sub>D</sub> =20A
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±30V
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =48V, V <sub>GS</sub> =0V
	-	-	10		V <sub>DS</sub> =48V, V <sub>GS</sub> =0V, T <sub>j</sub> =55°C
*R <sub>DSS(ON)</sub>	-	7.4	10.6	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =30A
	-	8.1	13.5		V <sub>GS</sub> =7V, I <sub>D</sub> =20A
<b>Dynamic</b>					
*Q <sub>g</sub>	-	34.8	-	nC	I <sub>D</sub> =30A, V <sub>DS</sub> =48V, V <sub>GS</sub> =10V
*Q <sub>gs</sub>	-	6.3	-		
*Q <sub>gd</sub>	-	16.7	-		
*t <sub>d(ON)</sub>	-	16	-	ns	V <sub>DS</sub> =30V, I <sub>D</sub> =30A, V <sub>GS</sub> =10V, R <sub>G</sub> =2.7Ω
*tr	-	21.6	-		
*t <sub>d(OFF)</sub>	-	38.2	-		
*t <sub>f</sub>	-	14.2	-		
C <sub>iss</sub>	-	1429	-	pF	V <sub>GS</sub> =0V, V <sub>DS</sub> =30V, f=1MHz
C <sub>oss</sub>	-	265	-		
C <sub>rss</sub>	-	129	-		
<b>Source-Drain Diode</b>					
*I <sub>s</sub>	-	-	60	A	
*V <sub>SD</sub>	-	0.86	1.2	V	I <sub>s</sub> =30A, V <sub>GS</sub> =0V
*trr	-	18.3	-	ns	I <sub>F</sub> =30A, V <sub>GS</sub> =0V, dI <sub>F</sub> /dt=100A/μs
*Q <sub>rr</sub>	-	13.6	-	nC	

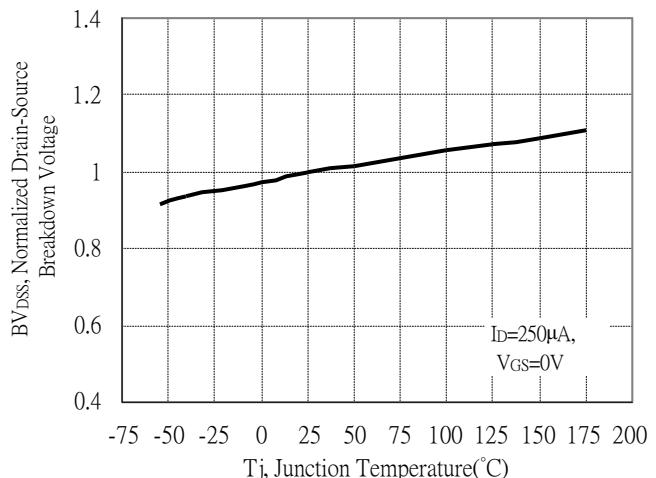
\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

## Typical Characteristics

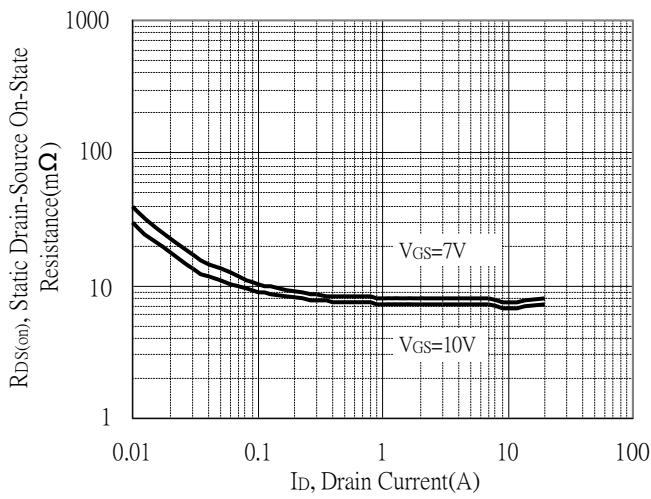
Typical Output Characteristics



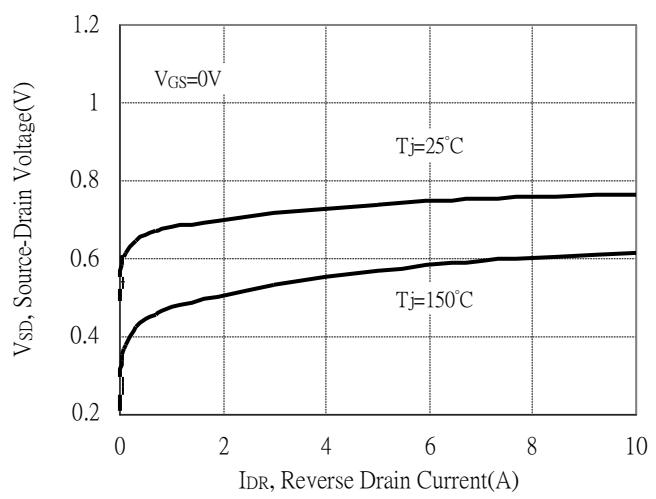
Breakdown Voltage vs Ambient Temperature



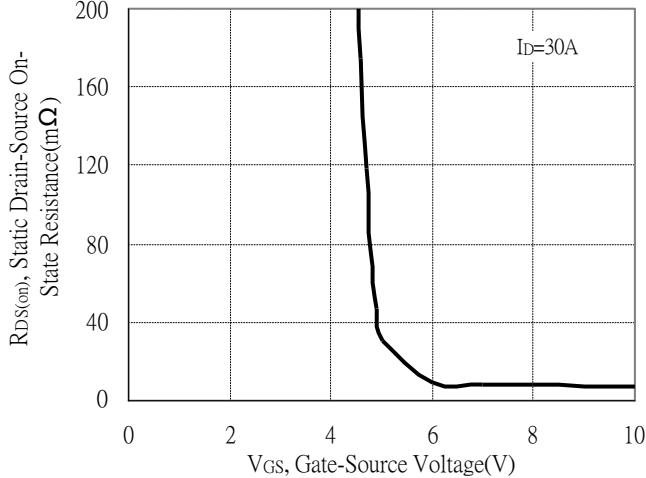
Static Drain-Source On-State resistance vs Drain Current



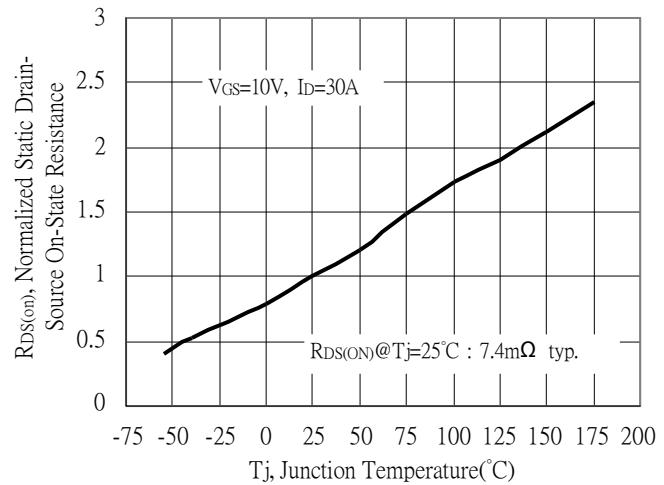
Reverse Drain Current vs Source-Drain Voltage



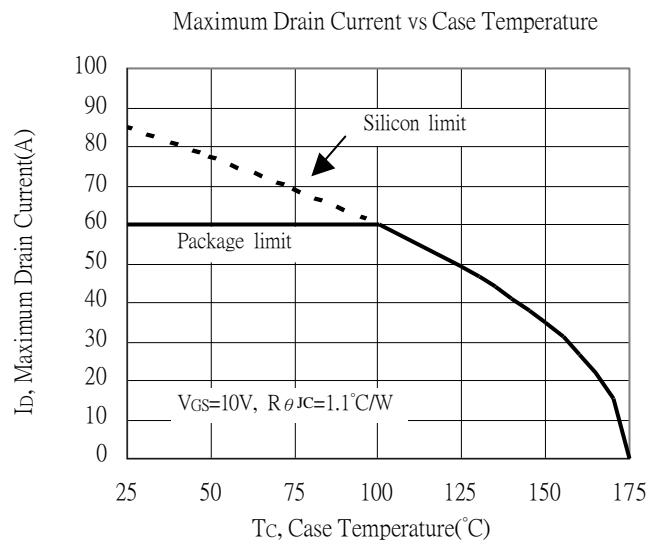
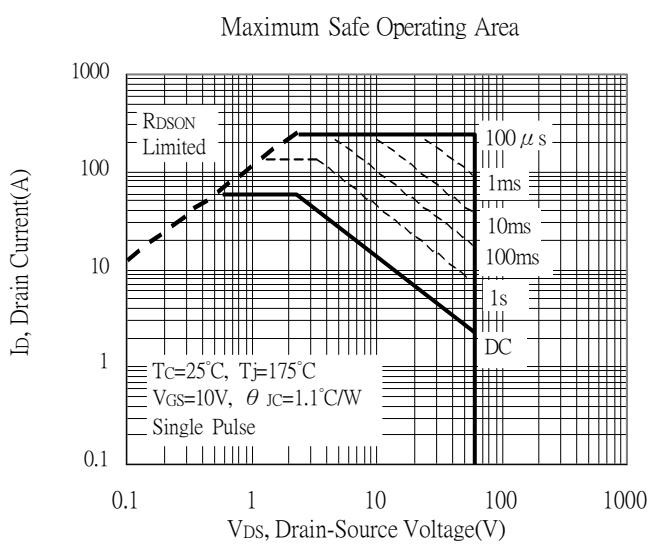
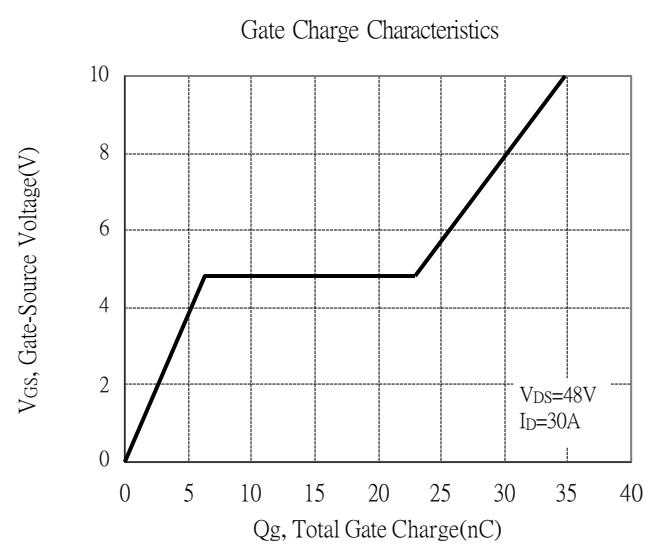
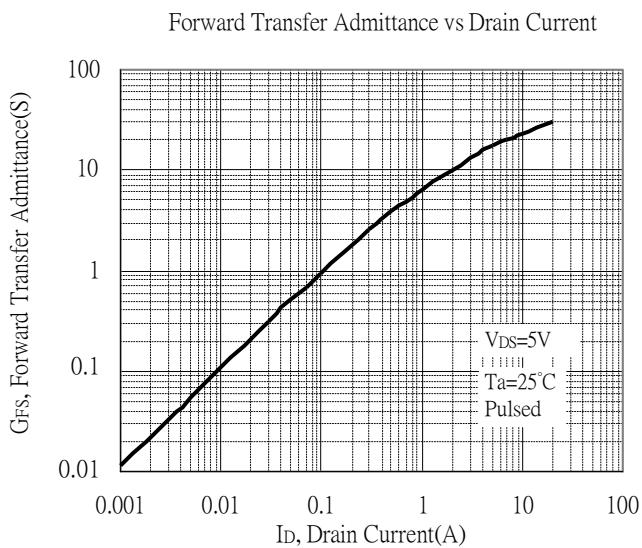
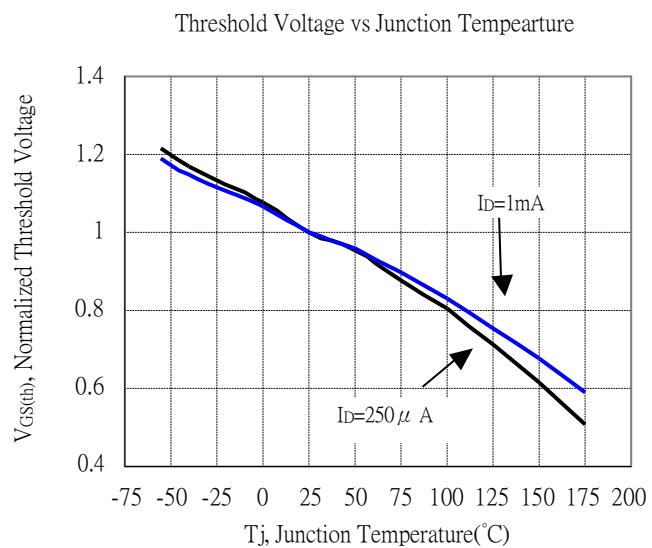
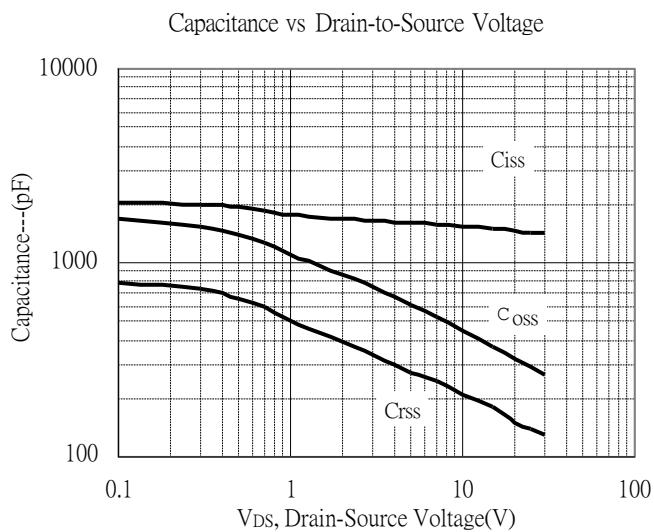
Static Drain-Source On-State Resistance vs Gate-Source Voltage



Drain-Source On-State Resistance vs Junction Temperature

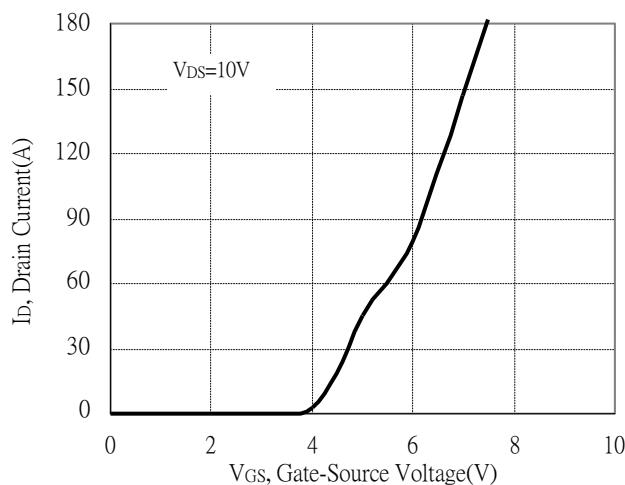


## Typical Characteristics(Cont.)

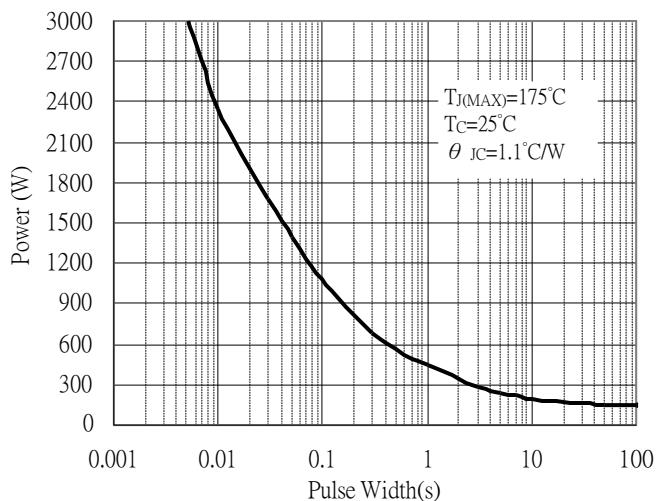


## Typical Characteristics(Cont.)

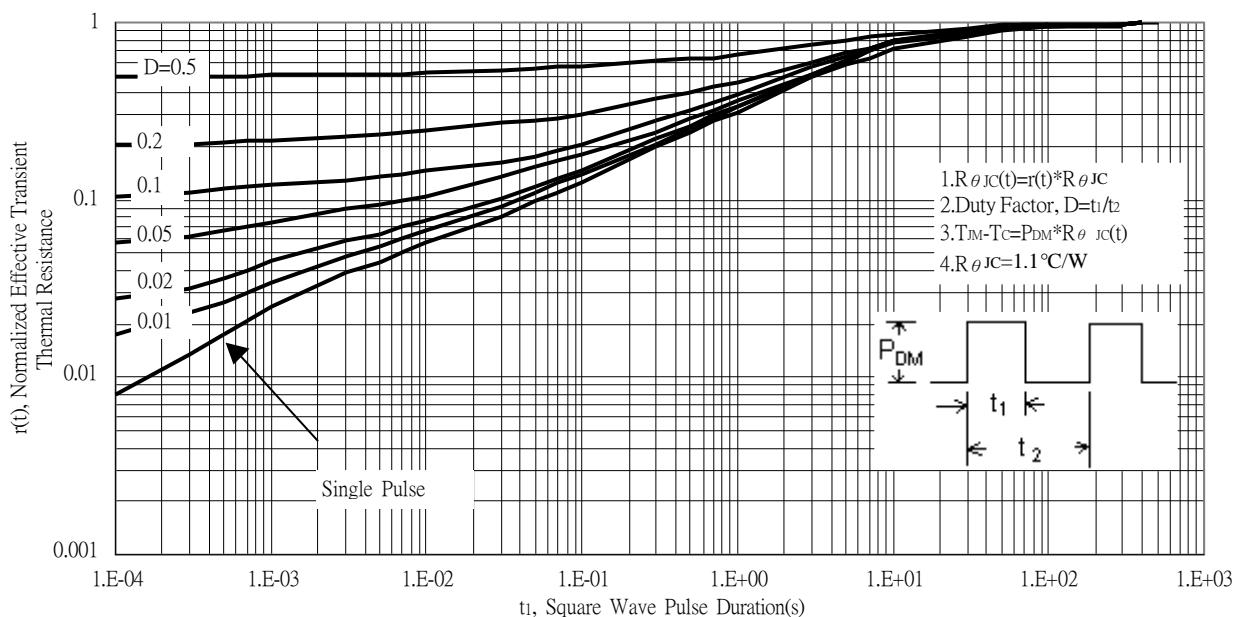
Typical Transfer Characteristics



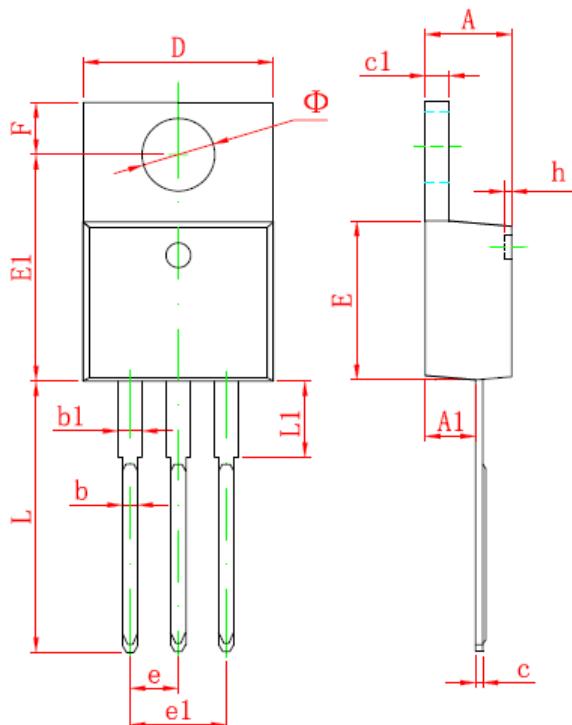
Single Pulse Power Rating, Junction to Case



Transient Thermal Response Curves

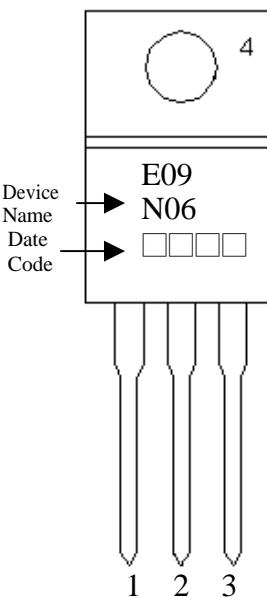


## TO-220 Dimension



3-Lead TO-220 Plastic Package

Marking:



Style: Pin 1.Gate 2.Drain 3.Source  
 4.Drain

\*: Typical

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	4.470	4.670	0.176	0.184	E1	12.060	12.460	0.475	0.491
A1	2.520	2.820	0.099	0.111	e	2.540*		0.100*	
b	0.710	0.910	0.028	0.036	e1	4.980	5.180	0.196	0.204
b1	1.170	1.370	0.046	0.054	F	2.590	2.890	0.102	0.114
c	0.310	0.530	0.012	0.021	h	0.000	0.300	0.000	0.012
c1	1.170	1.370	0.046	0.054	L	13.400	13.800	0.528	0.543
D	10.010	10.310	0.394	0.406	L1	3.560	3.960	0.140	0.156
E	8.500	8.900	0.335	0.350	Φ	3.735	3.935	0.147	0.155